

ZXMP6A16K 60V DPAK P-channel enhancement mode MOSFET

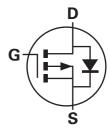
Summary

V _{(BR)DSS}	$R_{DS(on)}\left(\Omega\right)$	I _D (A)	
-60	0.085 @ V _{GS} = -10V	8.2	
-00	0.125 @ V _{GS} = -4.5V	6.75	



Description

This new generation trench MOSFET from Zetex features a unique structure combining the benefits of low on-resistance and fast switching, making it ideal for high efficiency power management applications.



Features

- · Low on-resistance
- · Fast switching speed
- · Low threshold
- · Low gate drive
- DPAK package

Applications

- · DC-DC converters
- · Power management functions
- Disconnect switches
- Motor control

D S N/C

Pinout - top view

Ordering information

Device	Device Reel size (inches)		Quantity per reel	
ZXMP6A16KTC	13	16	2500	

Device marking

ZXMP 6A16

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain-source voltage	V _{DSS}	-60	V
Gate-source voltage	V_{GS}	± 20	V
Continuous drain current @ V _{GS} = 10V; T _{amb} =25°C ^(b)	I _D	8.2	Α
@ V _{GS} = 10V; T _{amb} =70°C ^(b)		6.5	
@ V _{GS} = 10V; T _{amb} =25°C ^(a)		5.4	
Pulsed drain current ^(c)	I _{DM}	27.2	Α
Continuous source current (body diode) ^(b)	I _S	10	Α
Pulsed source current (body diode) ^(c)	I _{SM}	27.2	Α
Power dissipation at T _{amb} =25°C ^(a)	P _D	4.24	W
Linear derating factor		33.9	mW/°C
Power dissipation at T _{amb} =25°C ^(b)	P _D	9.76	W
Linear derating factor		78	mW/°C
Power dissipation at T _{amb} =25°C ^(d)	P _D	2.11	W
Linear derating factor		16.8	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to +150	°C

Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient ^(a)	$R_{\Theta JA}$	29.45	°C/W
Junction to ambient ^(b)	$R_{\Theta JA}$	12.8	°C/W
Junction to ambient ^(d)	$R_{\Theta JA}$	59.1	°C/W

NOTES:

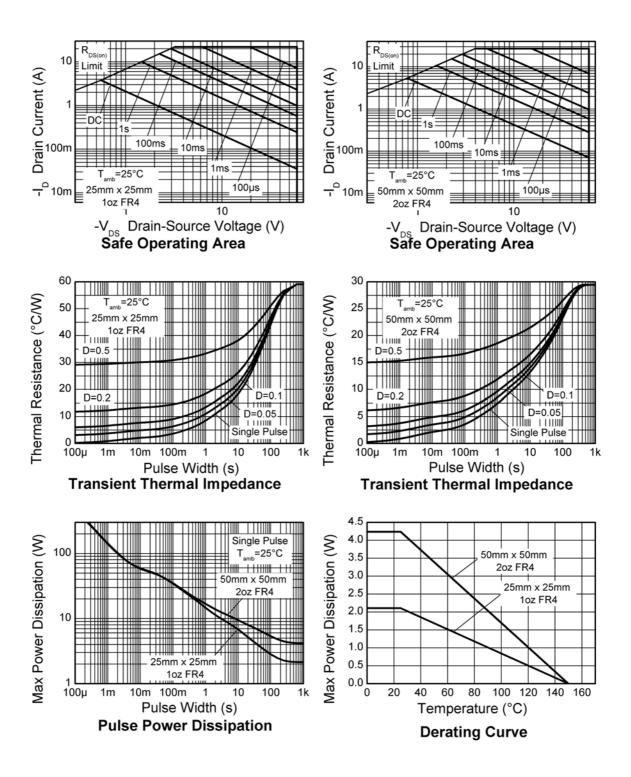
⁽a) For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.

⁽b) For a device surface mounted on FR4 PCB measured at t \leq 10 sec.

⁽c) Repetitive rating 50mm x 50mm x 1.6mm FR4 PCB, D=0.02 pulse width=300 μ s - pulse width limited by maximum junction temperature.

⁽d) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

Thermal characteristics



Electrical characteristics (at T_{amb} = 25°C unless otherwise stated)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Static	•	ı	ı	ı		
Drain-source breakdown voltage	V _{(BR)DSS}	-60			V	I _D = -250μA, V _{GS} =0V
Zero gate voltage drain current	I _{DSS}			-1.0	μΑ	V _{DS} = -60V, V _{GS} =0V
Gate-body leakage	I _{GSS}			100	nA	V _{GS} =±20V, V _{DS} =0V
Gate-source threshold voltage	V _{GS(th)}	-1.0			V	$I_D = -250 \mu A$, $V_{DS} = VGS$
Static drain-source on-state resistance (*)	R _{DS(on)}			0.085	Ω	V _{GS} = -10V, I _D = -2.9A
				0.125	Ω	$V_{GS} = -4.5V$, $I_D = -2.4A$
Forward transconductance(*) (‡)	9 _{fs}		7.2		S	V _{DS} = -15V, I _D = -2.9A
Dynamic ^(‡)						
Input capacitance	C _{iss}		1021		pF	V _{DS} = -30V, V _{GS} =0V
Output capacitance	C _{oss}		83		pF	f=1MHz
Reverse transfer capacitance	C _{rss}		56		pF	
Switching ^{(†) (‡)}						
Turn-on-delay time	t _{d(on)}		3.5		ns	V _{DD} = -30V, I _D = -1A
Rise time	t _r		4.1		ns	$R_{G} \approx 6.0 \Omega$, $V_{GS} = -10 V$
Turn-off delay time	t _{d(off)}		35		ns	
Fall time	t _f		10		ns	
Gate charge	Q_g		12.1		nC	V_{DS} = -30V, V_{GS} = -5V I_{D} = -2.9A
Total gate charge	Qg		24.2		nC	V _{DS} = -30V, V _{GS} = -10V
Gate-source charge	Q _{gs}		2.5		nC	I _D = -2.9A
Gate drain charge	Q _{gd}		3.7		nC	
Source-drain diode						
Diode forward voltage ^(*)	V _{SD}		-0.85	-0.95	V	T_j =25°C, I_S = -3.4A, V_{GS} =0V
Reverse recovery time ^(‡)	t _{rr}		29.2		ns	T _j =25°C, I _S = -2A,
Reverse recovery charge ^(‡)	Q _{rr}		39.6		nC	di/dt=100A/μs

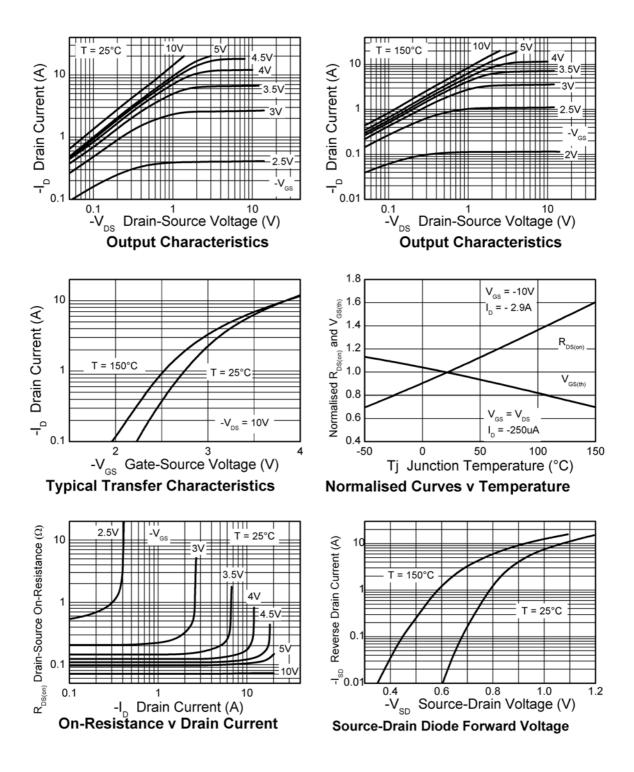
NOTES:

^(*) Measured under pulsed conditions. Pulse width = 300 μ s. Duty cycle \leq 2%.

^(†) Switching characteristics are independent of operating junction temperature.

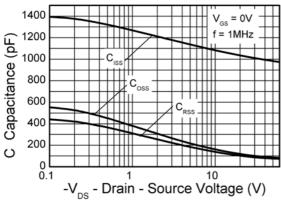
^(‡) For design aid only, not subject to production testing.

Typical characteristics

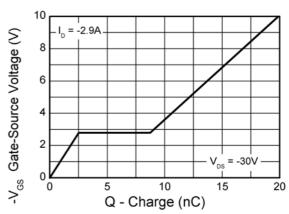


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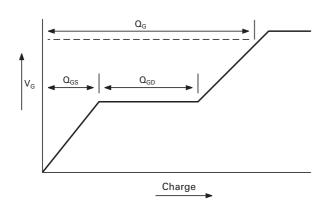
Typical characteristics



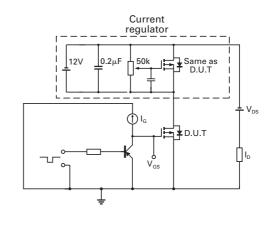
Capacitance v Drain-Source Voltage



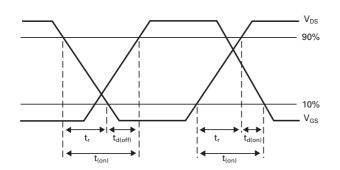
Gate-Source Voltage v Gate Charge

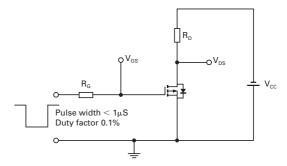


Basic gate charge waveform



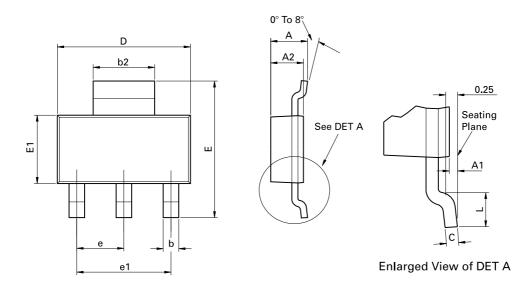
Gate charge test circuit





ZXMP6A16K

Package outline



Conforms to JEDEC TO-261 AA Issue B

DIM	Millin	neters	Inc	hes	DIM	Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
Α	-	1.80	-	0.071	е	2.30 BSC		0.0905 BSC	
A1	0.02	0.10	0.0008	0.004	e1	4.60	BSC	0.181	BSC
b	0.66	0.84	0.026	0.033	Е	6.70	7.30	0.264	0.287
b2	2.90	3.10	0.114	0.122	E1	3.30	3.70	0.130	0.146
С	0.23	0.33	0.009	0.013	L	0.90	-	0.355	-
D	6.30	6.70	0.248	0.264	-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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